

Search Notes

Application/Control No.

10/824,480

Examiner

Sang Y. Paik

Applicant(s)/Patent under
Reexamination

SUNG ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	443.1 450.1 451.1 452.11 452.12		
99	422 425 444 445 447		
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		3/13/06	28

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST TEST SEARCHED	3/13/06	28